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$\frac{\texttt{GENERAL} \ \ \texttt{INFORMATION} \ \ \texttt{REQUIRED}}{\texttt{FOR} \ \ \texttt{TYPE} \ \ \texttt{ACCEPTANCE}}$

- 2.983 (a,b,c) SEKAKU ELECTRON INDUSTRY CO., LTD. will manufacture the H38WT-203P in quantity, for use under FCC RULES PART 74.801, LOW POWER AUXILIARY STATIONS.
- 2.983 (d) TECHNICAL DESCRIPTION
 - (1) Type of Emission: 150KF3E

Bn = 2M + 2DK
 M = 1000
 D = 60.0KHz (Peak Deviation)
 K = 1
 Bn = 2(1K) + 2(60.0K)(1) = 2K +120.0K = 122.0KHz
 M = 15,000
 D = 60KHz
 K = 1

- 74.861(e)(5) ALLOWED AUTHORIZED BANDWIDTH = 200KHz.
 - (2) Frequency Range: Part 74: 161.625-161.775 & 174-216MHz
 TEST FREQ = 174.10MHz.
 - (3) Power Range and Controls: UNIT has no power controls.

Bn = 2(15K) + 2(60K) = 30 + 120 = 150KHz

- (4) Maximum Output Power Rating: 2.0 MilliWatts ERP.
- (5) DC Voltages and Current into Final Amplifier:

FINAL AMPLIFIER ONLY
9.0V BATTERY
Vce = 8.9 Volts
Ice = 1.6mA.

(6) Function of each electron tube or semiconductor device or other active circuit device:

SEE EXHIBIT #: 6A-6E

2.983(d) (7) Complete Circuit Diagrams: The circuit diagram is included as EXHIBIT 5. The block diagram is included as EXHIBIT 4. The part list is included EXHIBIT 6A-6E.

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- 2.983(d) (8) Instruction book. The instruction manual is included as last item in this report.
 - (9) Tune-up procedure. The tune-up procedure is given in page .
 - (10) Description of all circuitry and devices provided for determining and stabilizing frequency.

The transmitter frequency is controlled by a crystal, the crystal specifications are included in PAGE 7A-7E.

(11) Description of any circuits or devices employed for suppression of spurious radiation, for limiting modulation, and for limiting power. There are no devices or circuitry to limit the power, since this is a low power device. The interstage coupling between TR1, TR2, TR3, TR4, and TR6 as well as the low pass filter made up of L2, VC1, C26, L3, VC2, C28, L4, L6, VC3, & C29 suppress the harmonics.

Limiting Modulation:

The transmitter audio circuitry is contained in IC2. The modulation limiting is also provided by IC1B.

Limiting Power:

There is no provision for limiting power.

- (12) Digital modulation. This unit does not use digital modulation.
- 2.983(e) The data required by 2.985 through 2.997 is submitted below.
- 2.985(a) RF_power_output.

ERP was measured by the method described later in this report. The input power to the final stage was measured with a 9.0V supply connected in place of the 1.5V battery.

INPUT POWER: FOR 9.0 V OPERATION (8.9V)(0.0016A) = 14.3milliWatts

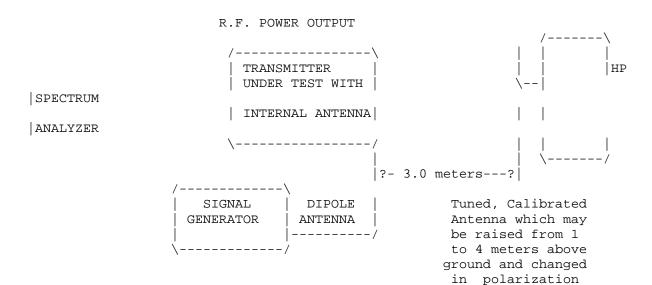
OUTPUT POWER: FOR 9.0 V OPERATION 4.0 mWATTS ERP

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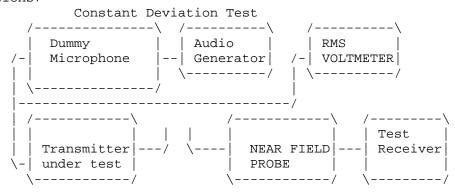


Equipment placed 1 meter above ground on a rotatable platform. The center of the Dipole antenna at the center of the platform and the output of the signal generator adjusted to produce the same meter reading as measured for the fundamental in the radiated emissions test.

2.987(a)(b) Modulation characteristics:

AUDIO FREQUENCY RESPONSE

The audio frequency response was measured in accordance with TIA/EIA Specification 603 S2.2.6.2.1. with the follwoing exceptions:



- 1. The test receiver audio bandwidth was <50Hz to >20,000Hz.
- 2. Apply a 1000Hz tone and adjust the audio generator to produce 10% of the rated system deviation.
- 3. Measure frequency responce over the frequency range from $100\mbox{Hz}$ to $20\,,000\mbox{Hz}\,.$

The audio frequency response curve is shown on the next page.

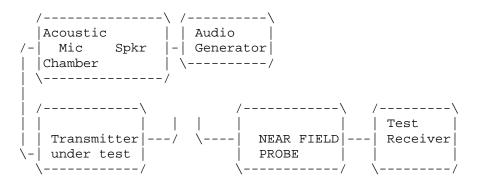
AUDIO LOW PASS FILTER

The audio low pass filter is not required in this unit.

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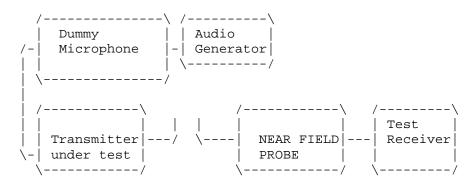
2.989(c) Occupied bandwidth: Using TIA/EIA 2.2.10 aAccoustic Microphone Sensitivity test procedure to determine if the UUT could be put into modulation limiting and limiting could not be reached, the maximum deviation was only +40KHz. Using this test procedure the frequency of maximum sensitivity was determined to be 500Hz. a.

Test procedure diagram OCCUPIED BANDWIDTH MEASUREMENT



b. Since the UUT could not be put into modulation limiting with an acoustic coupling a dummy microphone was used to connect to the UUT and a test procedure similar to TIA/EIA-603 S2.2.11 was used to measure the occupied bandwidth. Plots were made of the frequency of maximum sensitivity, at 10KHz and at the highest frequency for the UUT. Data in the plots show that all sidebands beyond the authorized bandwidth are less than 0.5% of the unmodulated carrier. The plot show the transmitter modulated with 10,000 Hz(the highest modulation frequency), adjusted for 50% modulation plus 16 dB. The spectrum analyzer was set with the unmodulated carrier at the top of the screen. The test procedure diagram and occupied bandwidth plots follow.

Test procedure diagram OCCUPIED BANDWIDTH MEASUREMENT



REQUIREMENT: PART 74: 200kHz EMISSION BANDWIDTH.

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2.993(a)(b) Field strength of spurious emissions:

NAME OF TEST: RADIATED SPURIOUS EMISSIONS

REQUIREMENTS: Emissions must be 43 +10log(Po) dB below the

mean power output of the transmitter.

 $43 + 10 \log(0.02) = 43 - 17.0 = 26.9 \text{ dB}$

TEST DATA:

EMISSION	METER	COAX		FIELD	ATT.		
FREQUENCY	READING	LOSS	ACF	STRENGTH	LEVEL	MARGIN	
MHz @	3m dBuV	dВ		dB d	.BuV/m	dВ	ANT.
174.10	81.50	0.90	17.02	99.42	0.00	0.00	H
348.10	24.40	1.40	15.49	41.29	58.13	28.14	H
522.00	6.70	1.60	19.48	27.78	71.65	41.66	H

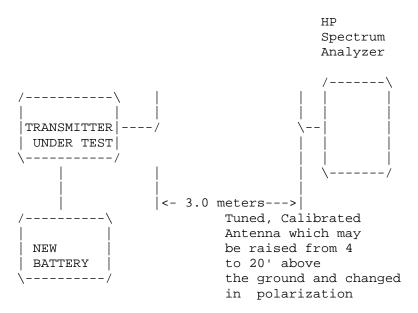
METHOD OF MEASUREMENT: The procedure used was C63.4-1992 operated into its own built-in antenna at a height of 1.5 meters above the ground plane. The spectrum was scanned from 30 to at least the tenth harmonic of the fundamental using a HP model 8566B spectrum analyzer, an Eaton model 94455-1 Biconical Antenna, ElectroMetrics antennas models TDA, TDS-25-1, TDS-25-2 RGA 180. Measurements were made at the open field test site of TIMCO ENGINEERING INC. located at 6051 N.W. 19th LANE, GAINESVILLE, FL. 32605.

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Equipment placed 4' above ground on a rotatable platform.

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2.995(a)(b)(d) Frequency stability:

Temperature and voltage tests were performed to verify that the frequency remains within the .0050%,(50 ppm) specification limit.

The test was conducted as follows: The transmitter was placed in the temperature chamber at 25 degrees C and allowed to stabilize for one hour. The transmitter was keyed ON for one minute during which four frequency readings were recorded at 15 second intervals. The worse case number was taken for temperature plotting. The assigned channel frequency was considered to be the reference frequency. The temperature was then reduced to -30 degrees C after which the transmitter was again allowed to stabilize for one hour. The transmitter was keyed ON for one minute, and again frequency readings were noted at 15 second intervals. The worst case number was recorded for temperature plotting. This procedure was repeated in 10 degree increments up to +50 degrees C.

MEASUREMENT DATA:

Assigned Frequency (Ref. Frequency): 194.810 000MHz

TEMPERATURE_C	FREQUENCY_MHz	PPM
-30	194.801 920	-41.47
-20	194.802 200	-40.44
-10	194.803 650	-32.59
0	194.804 780	-26.79
10	194.806 150	-19.76
20	194.808 930	- 5.49
30	194.811 620	+ 8.31
40	194.812 990	+15.34
50	194.812 130	+10.93

25c END BATT. Volt(3.0) = 2.25VDC 194.810 210 + 1.07

RESULTS OF MEASUREMENTS: The maximum frequency variation over the temperature range was -42.45 to +10.93 ppm. The maximum frequency variation at the battery end-point was +1.72 ppm.

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2.983(f)	Photo or Drawing of Label: See Exhibit 2.
2.983(g)	Photos of Equipment: See Exhibit 3A-3E.
2.997	Frequency Spectrum Investigated The Spectrum was investigated from 0.400 to at least the tenth harmonic of the fundamental.
2.999	Measurement Procedures for Type Acceptance:
	Measurement techniques have been in accordance with EIA specifications and the FCC requirements.
2.909	Certification of Technical Data by Engineers
	We, the undersigned, certify that the enclosed measurements and enclosed data are true and correct.

S.S. Sanders Engineer

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LIST OF TEST EQUIPMENT

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- Spectrum Analyzer: Hewlett Packard 8566B Opt 462, w/ preselector 85685A, & Quasi-Peak Adapter HP 85650A, & HP 8449B - OPT HO2 Cal. 7/6/99
- 2. Signal Generator, Hewlett Packard 8640B, cal. 10/1/98
- 3. Signal Generator, HP 8614A Serial No.2015A07428 cal. 5/27/99
- Eaton Biconnical Antenna Model 94455-1
 20-200 MHz Serial No. 0997 Cal. 10/30/98
- 4. Electro-Metric Dipole Kit, 20-1000 MHz, Model TDA-30 10/31/98
- 5. Electro-Metric Horn 1-18 GHz, Model RGA-180, Cal. 10/30/98
- 6. Electro-Metric Antennas Model TDA-30/1-4, Cal. 10/15/98
- 7. Electro-Metric Line Impedance Stabilization Network Model No. EM-7821, Serial No. 101; 100KHz-30MHz 50uH. Cal.11/19/98
- 8. Electro-Metric Line Impedance Stabilization Network Model No. EM-7820, Serial No. 2682; 10KHz-30MHz 50uH. Cal. 11/19/98
- 9. Special low loss cable was used above 1 GHz
- 10. Tenney Temperature Chamber

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